

Equations

Harris eqs

Cornerness

$$E(u, v) = \sum w(x, y) [I(x + u, y + v) - I(x, y)]^2$$

Taylor series 2D first order approx

$$f(x + u, y + v) \approx f(x, y) + (u f_x(x, y) + v f_y(x, y))$$

Harris Corner Derivation

$$\sum [I(x + u, y + v) - I(x, y)]^2$$

Use first order approx to get:

$$\sum u^2 I_x^2 + 2uv I_x I_y + v^2 I_y^2$$

Written in a matrix equation this is:

$$\begin{bmatrix} u & v \end{bmatrix} = \left(\sum \begin{bmatrix} I_x^2 & I_x I_y \\ I_x I_y & I_y^2 \end{bmatrix} \right) \begin{bmatrix} u \\ v \end{bmatrix}$$

The quadratic approx simplifies to:

$$E = (u, v) \cong [u, v] M \begin{bmatrix} u \\ v \end{bmatrix}$$

Where M is a 2x2 matrix computed from image derivatives:

$$M = \sum w(x, y) \begin{bmatrix} I_x^2 & I_x I_y \\ I_x I_y & I_y^2 \end{bmatrix}$$

Harris corner response can be measure from the eigenvalues of M; If both λ_1 and λ_2 are great, it's a corner. If only one is, it's an edge. If both are smol, it's a flat area. Eigenvalues are however slow to compute, so the following function can be used instead:

$$R = \det M - k(\text{trace} M)^2$$

because

$$\det M = \lambda_1 \lambda_2$$

$$\text{trace} M = \lambda_1 + \lambda_2$$

k is an empirical constant

finding edges, scale space

Sobel operator, common approx of DoG

$$S_x = \begin{bmatrix} -1 & 0 & 1 \\ -2 & 0 & 2 \\ -1 & 0 & 1 \end{bmatrix}$$

$$S_y = \begin{bmatrix} 1 & 2 & 1 \\ 0 & 0 & 0 \\ -1 & -2 & -2 \end{bmatrix}$$

Second derivative of Gaussian = Laplacian of Gaussian
Laplacian image:

$$f = L_{Kernel} * Image$$

Kernel:

$$L = \sigma^2 (G_{xx}(x, y, \sigma) + G_{yy}(x, y, \sigma))$$

Where Gaussian:

$$G(x, y, \sigma) = \frac{1}{\sqrt{2\pi}\sigma} e^{-\frac{x^2+y^2}{2\sigma^2}}$$

DoG Pyramid:

$$\begin{aligned} D(x, y, \sigma) &= (G(x, y, k\sigma) - G(x, y, \sigma)) * I(x, y) \\ &= L(x, y, k\sigma) - L(x, y, \sigma) \end{aligned}$$

Laplacian of Gaussian

$$LoG(x, y, t) = -\frac{1}{\pi t^2} \left(1 - \frac{x^2 + y^2}{2t}\right) e^{-\frac{x^2+y^2}{2t}}$$

SIFT

The Hessian matrix can be defined as

$$H_{i,j} = \frac{\partial^2 f}{\partial x_i \partial x_j}$$

In SIFT, keypoints that do not satisfy the following equation are eliminated, because they are on the edge, and thus not as valuable as corner points.

$$\frac{\text{trace}(H)^2}{\det(H)} < \frac{(r+1)^2}{r}$$

Nonlinear scale space

Nonlinear diffusion filtering

$$\frac{\partial L}{\partial t} = \text{div}(c(x, y, t) * \nabla L)$$

Where c is the conductivity function, which enables adaptation to the image structure. t is the scale parameter, larger values lead to simpler images.

AOS (Additive Operator Splitting) schemes, which are used for iteratively constructing nonlinear scale spaces

$$L^{i+1} = (I - \tau \sum_{t=1}^m A_t(L^i))^{-1} L^i$$

FED (Fast Explicit Diffusion) is a faster way to construct the scale space Given *a priori* $L^{i+1,0} = L^i$, a FED cycle is:

$$L^{i+1,j+1} = (I + \tau_j A(L^i)) L^{i+1,j}, j = 0 \dots n-1, i = 0 \dots M$$

The main idea is to perform M cycles of n explicit diffusion steps with varying step sizes τ_j :

$$\tau_j = \frac{\tau_{max}}{2 \cos^2(\pi \frac{2j+1}{4n+2})}$$

Loss equations for CNN based descriptors and pipelines

Hinge loss for L2 distance metric. p_1 & p_2 are patches, C is upper bound loss.

$$l(x_1, x_2) = \begin{cases} \|D(x_1) - D(x_2)\|_2, & p_1 = p_2 \\ \max(0, C - \|D(x_1) - D(x_2)\|_2), & p_1 \neq p_2 \end{cases}$$

Overall loss function for end-to-end pipeline

$$\mathcal{L}(p_i) = \|g(p_i^1, f_w(p_i^1)) - g(p_i^2, f_w(p_i^2))\|_2^2$$

$f_w(p_i^*)$ = orientation for patch p of ith pair

$g(p, x)$ = patch descriptor for patch p, rotated to x degree

Training makes $f_w(p_i^*)$ converges to an orientation estimator pointing to the dominant direction of patch p.

TILDE losses

Loss 1: classification-like loss

$$\mathcal{L}_c(\omega) = \gamma_c \|\omega\|_2^2 + \frac{1}{K} \sum_{i=1}^2 \max(0, 1 - y_i F(x_i; \omega))^2$$

For the ith sample x_i , induce $F(x_i; \omega)$ to be close to +1 for positive samples ($y_i = +1$) and -1 for negative samples ($y_i = -1$)

Loss 2: shape regularizer loss, to normalize the response for positive samples

$$\mathcal{L}_s(\omega) = \frac{\gamma_s}{K_p} \sum_{i|y_i=+1} \sum_n \|w_{n\eta_i(n)} * x_i (w_{n\eta_i(n)}^T x_i) h\|_2^2$$

$$h(x, y) = e^{\alpha(1 - \frac{\sqrt{x^2+y^2}}{s})} - 1$$

Loss 3: temporal regularizer loss, to enforce repeatability of varying illumination conditions

$$\mathcal{L}_t(\omega) = \frac{\gamma_t}{K} \sum_{i=1}^K \sum_{j \in N_i} (F(x_i; \omega) - F(x_j; \omega))^2$$